

<b>Notice of References Cited</b>	Application/Control No. 10/663,757		Applicant(s)/Patent Under Reexamination HAYASHI, EIJI	
	Examiner Terence Boes		Art Unit 3682	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,170,336	02-1965	BOHNHOFF ARTHUR F	74/424.86
*	B	US-6,282,971	09-2001	Shirai et al.	74/424.87
*	C	US-4,677,869	07-1987	Mayfield, Ralph W.	74/424.83
*	D	US-5,245,884	09-1993	Langley, Neil	74/424.83
*	E	US-2,995,948	08-1961	GALONSKA DAVID A; et. al.	74/424.87
*	F	US-2002/0026844	03-2002	Fujita, Satoshi	74/424.86
*	G	US-2002/0078774	06-2002	Kajita, Toshiharu	74/424.82
*	H	US-2002/0056330	05-2002	Nishide, Tetsuhiro	74/89.44
*	I	US-5,988,007	11-1999	Nishimura, Kentaro	74/424.87
*	J	US-5,193,409	03-1993	Babinski, James A.	74/424.83
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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